

## LMP3117XF 30V P-Channel MOSFET

### Features

- -30V/-42A,  $R_{DS(ON)}=14.5m\Omega@V_{GS}=-10V$
- Fast switching
- Suit for -4.5V Gate Drive Applications
- Green Device Available
- DFN5X6-8L package design

### Product Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been

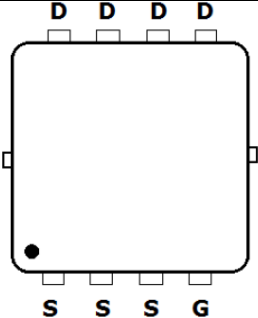
especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

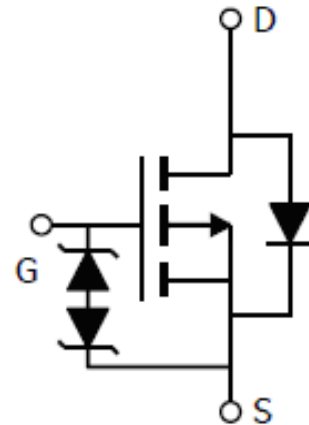
These devices are well suited for high efficiency fast switching applications..

### Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Application

### Pin Configuration

LMP3117XF (DFN5X6-8L)	
	
PIN	Description
1	Source
2	Source
3	Source
4	Gate
5	Drain
6	Drain
7	Drain
8	Drain



**Ordering Information**

Ordering Information					
Part Number	P/N	PKG code	Pb Free code	Package	Quantity
LMP3117XF	LMP3117	X	F	DFN5X6-8L	3000

**Marking Information**

Marking Information		
Part Marking	Part Number	LFC code
3117XF XWMMMM	3117XF	XWMMMM

**Absolute Maximum Ratings**

(T<sub>C</sub>=25°C Unless otherwise noted)

Symbol	Parameter	Typical	Unit
V <sub>DS</sub>	Drain-Source Voltage	-30	V
V <sub>GS</sub>	Gate-Source Voltage	±25	V
I <sub>D</sub>	Continuous Drain Current	TC=25°C	A
		TC=100°C	
I <sub>DM</sub>	Pulsed Drain Current	-140	A
P <sub>D</sub>	Power Dissipation	TC=25°C	W
		TC=100°C	
T <sub>J</sub>	Operating Junction Temperature	-55 to +150	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to +150	°C
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient	50	°C/W
R <sub>θJC</sub>	Thermal Resistance-Junction to Case	3	°C/W

## Electrical Characteristics

( $T_C=25^{\circ}\text{C}$  Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	-30			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	-1.2	-1.6	-2.5	
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±25V			±100	uA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V			-1	uA
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-10A		11.9	14.5	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-6A		19	23	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =-1A, V <sub>GS</sub> =0V			-1	V
Dynamic						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-15V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-15A		22		nC
Q <sub>gs</sub>	Gate-Source Charge			8.7		
Q <sub>gd</sub>	Gate-Drain Charge			7.2		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V f=1MHz		2215		pF
C <sub>oss</sub>	Output Capacitance			310		
C <sub>rss</sub>	Reverse Transfer Capacitance			237		
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =-15V, I <sub>D</sub> =-15A V <sub>GS</sub> =-10V, R <sub>G</sub> =3.3Ω		8		ns
t <sub>r</sub>				73.67		
t <sub>d(off)</sub>	Turn-Off Time			61.8		
t <sub>f</sub>				24.4		

### Note

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2oz copper.
2. The EAS data shows Max. rating . The test condition is  $V_{DD}=-20V, V_{GS}=-10V, L=0.1mH, I_{AS}=-19A$ .
3. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$ .

## Typical Performance Characteristics

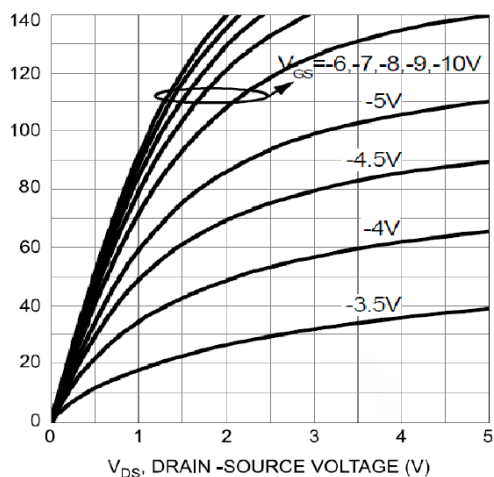


Figure 1. Output Characteristics

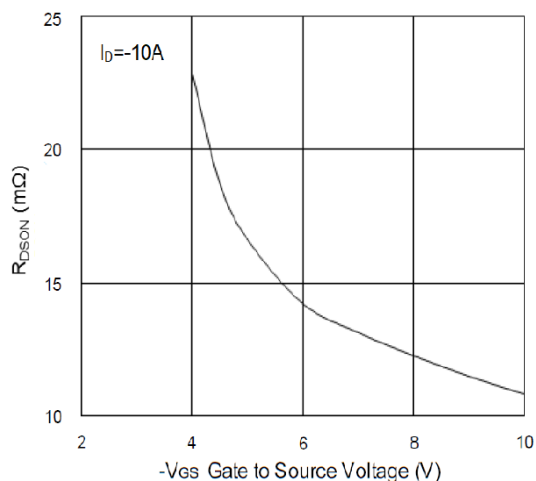


Figure 2. On-Resistance Variation with  $V_{GS}$

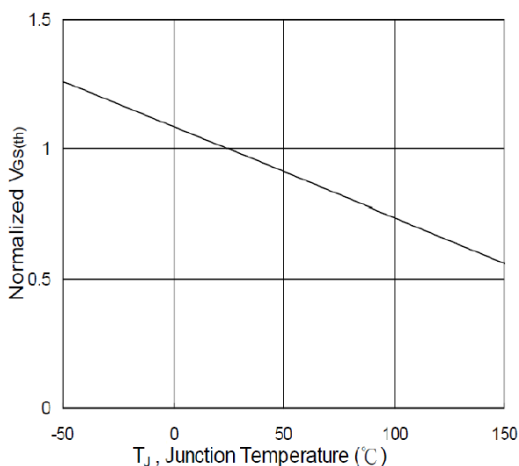


Figure 3. Normalized  $V_{GS(th)}$  vs.  $T_J$

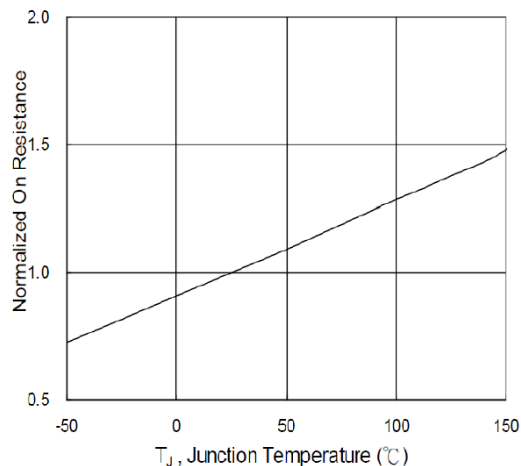


Figure 4. Normalized  $R_{DS(on)}$  vs.  $T_J$

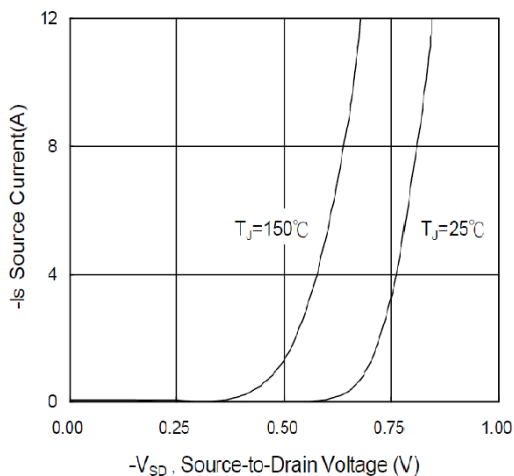


Figure 5. Diode Forward Voltage vs. Current

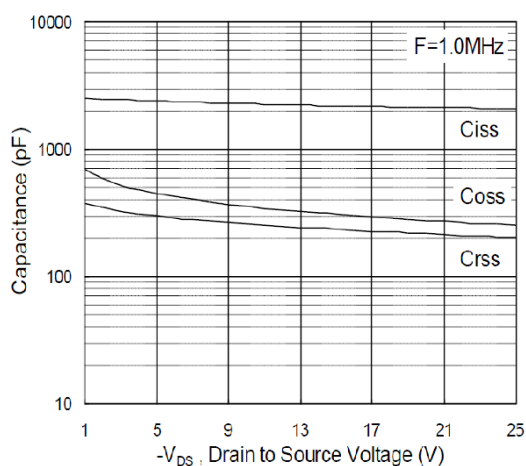


Figure 6. Capacitance

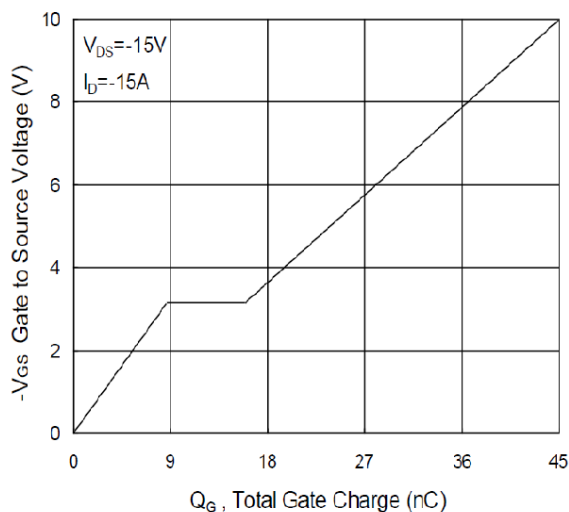
**Typical Performance Characteristics(continue)**


Figure 7. Gate Charge Waveform

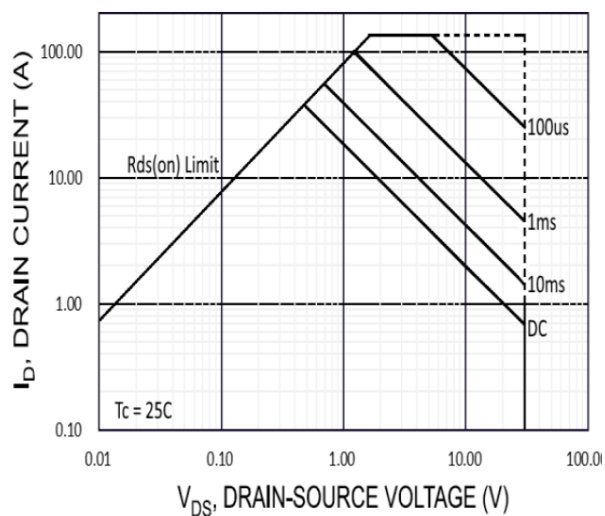


Figure 8. Maximum Safe Operating Area

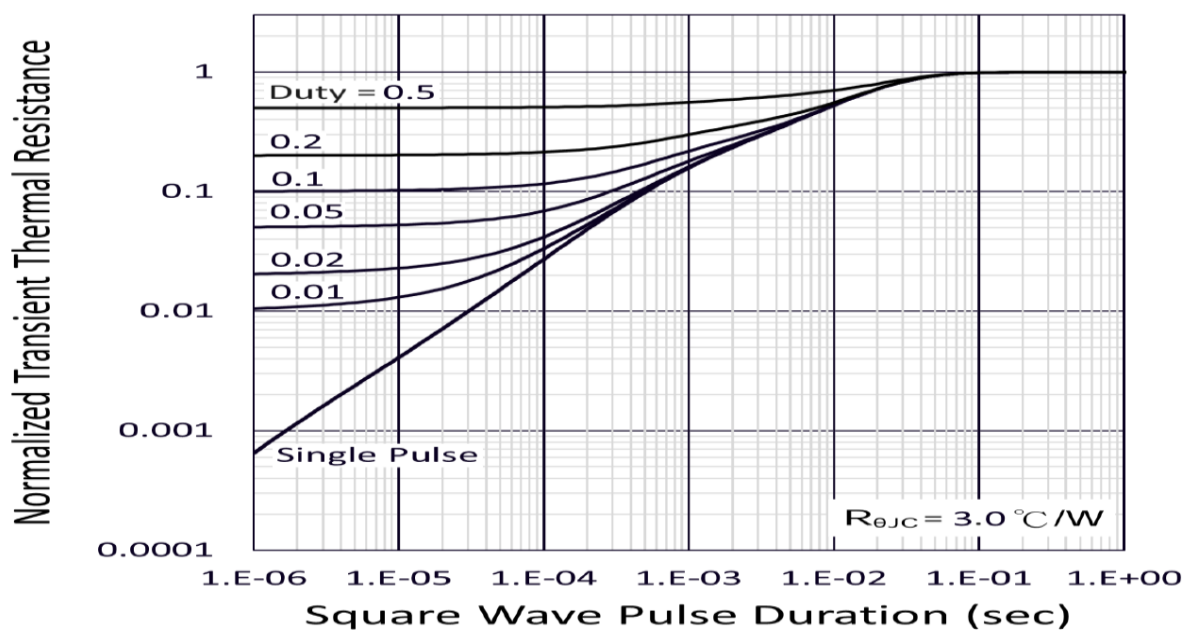
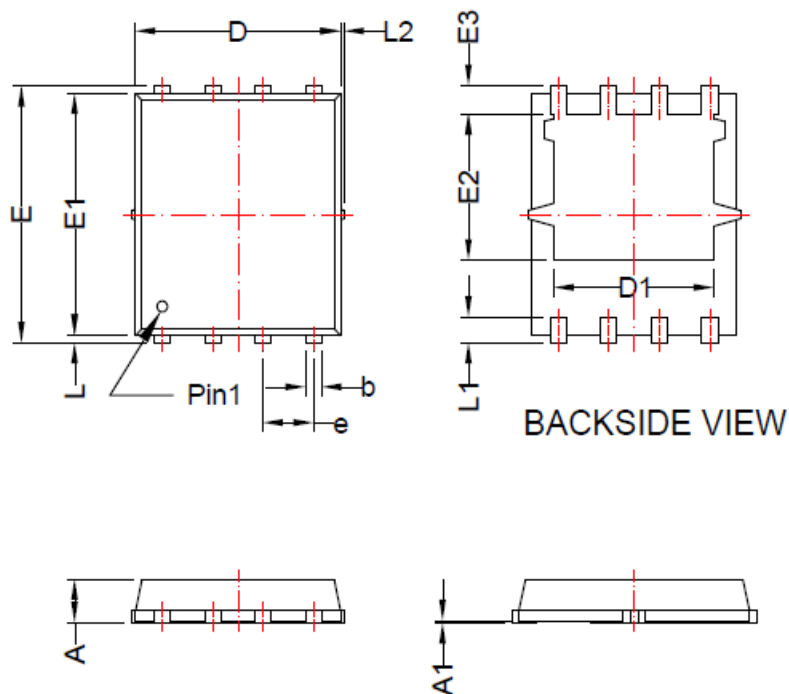


Figure 9. Normalized Transient Thermal Resistance

**Package Dimension:**

# **DFN5X6-8L**



DIMENSION D AND E1 DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.5mm PER INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.5mm PER SIDE

Dimensions				
Symbol	Millimeters		Inches	
	Min	Max	Min	Max
<b>A</b>	0.80	1.20	0.031	0.047
<b>A1</b>	0.00	0.05	0.000	0.002
<b>b</b>	0.25	0.51	0.010	0.020
<b>c</b>	0.20	0.35	0.008	0.014
<b>D</b>	4.90	5.40	0.193	0.213
<b>D1</b>	3.40	4.60	0.134	0.181
<b>e</b>	1.27 BSC		0.050 BSC	
<b>L</b>	0.1	0.25	0.004	0.010
<b>L1</b>	0.45	0.75	0.018	0.030
<b>L2</b>	---	0.15	---	0.006

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